


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/708,355	HSIEH, HSIANG-AN	
	Examiner	Art Unit	
	Yaima Campos	2185	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EIC PLUS search	3/16/2006	YC
PALM and EAST inventor name search	3/16/2006	YC
Text search within class 711 and subclasses 711/103,115,118	3/16/2006	YC